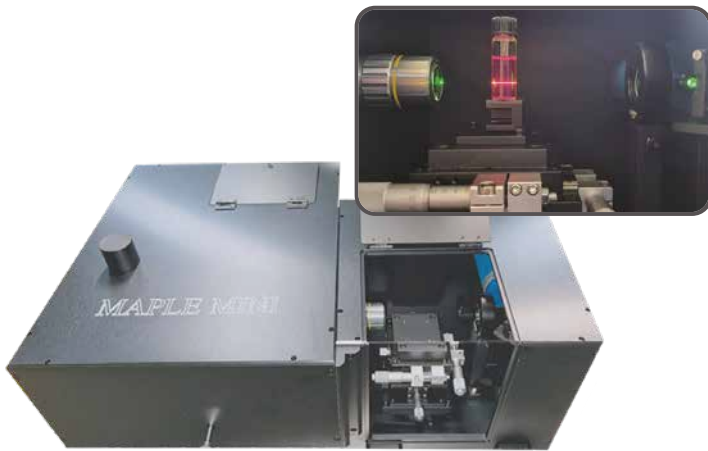


# Maple Mini | Micro Raman / PL



## Key Features

- Free or Fiber Coupled
- Compact & Modular Design
- Various Laser Line Combined

## Application

- Semiconductor Characterization and Testing (III-V Materials)
- GaN / ZnO LED Wafer Surface Characterization (Surface Containment, Uniformity, Reflectivity, Thickness and Bowing Test)
- Solar Cell EL Measurement
- Sensor Development for NIR Range
- Gemstone PL, Diamond by HPTP
- Development of Material of LED with GaN / GaAs
- Reflectance & Transmittance Measurement (SiC / Si / Sapphire Substrate)
- Photoluminescence Excitation (PLE) to Measure the Energy Levels (Properties of Absorption & Recombination)

## Specification

### Excitation Source

Wavelength	532 / 635 / 785 nm (Select One Laser)
Beam Quality	<1.2 M <sup>2</sup>
Output Power	100 mW (CW Mode)

### Spectrograph

Focal Length	320 mm (Two exit port)
Spectral Resolution	0.1 nm
Spectrometer (Option)	Fiber Optics Spectromter

### Sample Chamber

Maple Mini	Compact Type Micro Sample Chamber Manual Type Stage & Filter Wheel
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### Detector

Type	PMT (R928) / Si / InGaAs
Spectral Range	185 ~ 900 nm / 900 ~ 1800 nm
Type (CCD)	TE Cooled CCD (Open Electrode)
Pixel Format	1024 * 256

### Software

Solis & Monoworks	User-friendly Interface for Simultaneous Detector & Spectrograph Control
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